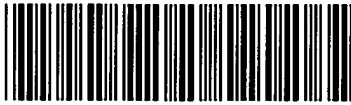


**Search Notes**

Application/Control No.

10/733,453

Examiner

Mark A. Chapman

Applicant(s)/Patent under  
Reexamination

OYA ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	110.1	11/9/2005	MC
	111.4		
	120		
399	262		
	111		
	119		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	11/9/2005	MC